

**GigaDevice Semiconductor Inc.**

**Arm® Cortex®-M3/4/23/33 32-bit MCU**

**Application Note  
AN021**

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## 1. Introduction

In the process of MCU development, there are some problems, such as measuring the execution time of some codes or algorithms, comparing the running time of codes before and after optimization, and whether the waiting period designed in the code is accurate enough. This application note is based on gd32f10x series, using gd32f103c-eval development board, and the development environment is keil 5.27, four methods to measure code execution time are provided.

- Measure with timer
- Measure with systick counter
- Measure with gpio flip
- Measure with Keil online simulation

## 2. Implementation of measuring code running time

## 2.1. Measurement with Timer

The working frequency of MCU system clock is 108MHz, the division factor of Timer1 is 108, and the counter value is 10000. Set timer update interrupt and enable Timer1 update event interrupt. The configuration of Timer1 is shown in [Table 2-1. Timer1 configuration parameters](#).

**Table 2-1. Timer1 configuration parameters**

```

/***
\brief      configure the TIMER peripheral
\param[in]  none
\param[out] none
\retval     none
*/
void timer_config(void)
{
    /* -----
    *-----[TIMER1 Configuration]
    *----- */
    timer_parameter_struct timer_initpara;
    rcu_periph_clock_enable(RCU_TIMER1);
    timer_deinit(TIMER1);
    /* initialize TIMER init parameter struct */
    timer_struct_para_init(&timer_initpara);
    /* TIMER1 configuration */
    timer_initpara.prescaler        = 107;
    timer_initpara.alignedmode      = TIMER_COUNTER_EDGE;
    timer_initpara.counterdirection = TIMER_COUNTER_UP;
    timer_initpara.period           = 9999;
    timer_initpara.clockdivision    = TIMER_CKDIV_DIV1;
    timer_init(TIMER1, &timer_initpara);
    timer_interrupt_flag_clear(TIMER1, TIMER_INT_FLAG_UP);
    timer_interrupt_enable(TIMER1, TIMER_INT_UP);
}

/***
\brief      configure the TIMER1 interrupt
\param[in]  none
\param[out] none
\retval     none
*/

```

```
* /  
void nvic_config(void)  
{  
    nvic_priority_group_set(NVIC_PRIGROUP_PRE1_SUB3);  
    nvic_irq_enable(TIMER1_IRQn, 1, 1);  
}
```

Define the external variable `cnt_cycle`. When the timer is updated with 1ms event, `cnt_cycle` plus one in the update interrupt.

**Table 2-2. Timer1 interrupt handle function**

```
extern uint32_t cnt_cycle;

/*
 \brief      this function handles TIMER1 interrupt request.
 \param[in]   none
 \param[out]  none
 \retval     none
 */

void TIMER1_IRQHandler(void)
{
    if(SET == timer_interrupt_flag_get(TIMER1, TIMER_INT_FLAG_UP)){
        /* clear the update event interrupt flag bit */
        timer_interrupt_flag_clear(TIMER1, TIMER_INT_FLAG_UP);
        ++cnt_cycle;
    }
}
```

Write the code segment to be measured. In this project, 108 `__nop()` is written in the function `delay_1us`, that is, the code runs for 108 clock cycles for 1us. The code is shown in [Table 2-3. Test code function.](#)

**Table 2-3.** Test code function

## Several methods of measuring MCU code running time

```

__nop(); __nop(); __nop(); __nop(); __nop(); __nop(); __nop(); __nop(); __nop(); \
__nop(); __nop(); __nop(); __nop(); __nop(); __nop(); __nop(); __nop(); __nop(); \
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__nop(); __nop(); __nop(); __nop(); __nop(); __nop(); __nop(); __nop(); __nop(); \
__nop(); __nop(); __nop(); __nop(); __nop(); __nop(); __nop(); __nop(); __nop(); \
}while(0)

/*
\brief      delay nms
\param[in]  nms: delay nms ms
\param[out] none
\retval     none
*/
void delay_nms(uint32_t nms)
{
    uint32_t nus=nms*1000;
    while(--nus)
    {
        delay_1us();
    }
}

```

Time start function measure\_ runtime\_ start and measure\_ runtime\_end is shown in [Table 2-4. Timer measures start and end functions.](#)

**Table 2-4. Timer measures start and end functions**

```

/*
\brief      start measure
\param[in]  none
\param[out] none
\retval     none
*/
void measure_runtime_start()
{
    cnt_cycle = 0;
    timer_enable(TIMER1);
}

/*
\brief      end measurement
\param[in]  none
\param[out] none
\retval     measure time

```

## Several methods of measuring MCU code running time

```
/*
float measure_runtime_end()
{
    float work_time;
    uint32_t cnt_num,tmp;
    cnt_num = TIMER_CNT(TIMER1);
    timer_disable(TIMER1);
    nvic_irq_disable(TIMER1_IRQn);
    tmp = cnt_cycle*10000 + cnt_num;
    work_time = (float)tmp/1000.0;
    return work_time;
}
```

Write code in the main function to measure the time of the code to be executed, and print it through the serial port. The code is shown in [Table 2-5. Timer measures start and end functions.](#)

**Table 2-5. Timer measures start and end functions**

```
/*!
 \brief      main function
 \param[in]   none
 \param[out]  none
 \retval     none
*/
int main(void)
{
    gd_eval_com_init(EVAL_COM0);
    dbg_periph_enable(DBG_TIMER1_HOLD);
    timer_config();
    nvic_config();
    measure_runtime_start();
    delay_nms(1);
    rtimevla = measure_runtime_end();
    printf("The code run time is %f ms",rtimevla);
    while(1){

    }
}
```

The measurement results are printed by the upper computer, and the results are shown in [Figure 2-1. Timer 1 measures the running time of the code and prints the result.](#)

**Figure 2-1. Timer 1 measures the running time of the code and prints the result**



## 2.2. Measurement with systick counter

SysTick is a 24-bit countdown timer. When it counts to 0, it will automatically reload the initial value of the timing from the RELOAD register. In this section, systick uses the system clock as the clock input, and configures the systick interrupt to enter an interrupt every 1ms. Write the functions start\_time, stop\_time, and get\_time to represent the start of the code timing, the end of the code timing and get the code running time. The function is shown in [Table 2-6.](#)

### [Systick configuration function.](#)

**Table 2-6. Systick configuration function**

```
uint32_t tick;
/*!
 \brief      strat time
 \param[in]  none
 \param[out] none
 \retval     none
 */
void start_time(void) {
    tick = 0;
    /* setup systick timer for 1000Hz interrupts */
    if (SysTick_Config(SystemCoreClock / 1000)){
        /* capture error */
        while (1){
    }}
```

## Several methods of measuring MCU code running time

```

    }

    /* configure the systick handler priority */
    NVIC_SetPriority(SysTick_IRQn, 0x00U);
}

/*!
 \brief      stop time
 \param[in]  none
 \param[out] none
 \retval     none
*/
void stop_time(void) {
    SysTick->CTRL &= SysTick_Counter_Disable;
    SysTick->VAL = SysTick_Counter_Clear;
}

/*!
 \brief      get time
 \param[in]  none
 \param[out] none
 \retval     none
*/
uint32_t get_time(void) {
    uint32_t elapsed = (uint32_t)tick;
    return elapsed;
}

/*!
 \brief      this function handles SysTick exception
 \param[in]  none
 \param[out] none
 \retval     none
*/
void SysTick_Handler(void)
{
    ++tick;
}

```

The code in the main function is shown in [Table 2-7. The main function of systick measuring code running time](#).

**Table 2-7. The main function of systick measuring code running time**

```

/*!
 \brief      main function
 \param[in]  none

```

## Several methods of measuring MCU code running time

```
\param[out] none
\retval    none
*/
int main(void)
{
    uint32_t value;
    gd_eval_com_init(EVAL_COM0);

    start_time();
    delay_nms(3);
    stop_time();
    value=get_time();
    printf("The code run time is %d ms",value);
    while(1){

    }
}
```

The code running time measurement results are as follows:

**Figure 2-2. Systick measurement code running time result printing**



**Note:** By changing the parameter of the SysTick\_Config() function to change the base time of the systick timer entering the interrupt.

## 2.3. Measure with gpio flip

Configure GPIO PA1 to push-pull output mode, the default output is low level, configure the PA1 pin is pulled high before the code segment to be measured, and the level is pulled high after the code is run. Use the logic analyzer or oscilloscope trigger mode to test the code running time. The code is shown in [Table 2-8. GPIO flip configuration and main function](#).

**Table 2-8. GPIO flip configuration and main function**

```
/*
\brief      main function
\param[in]  none
\param[out] none
\retval     none
*/
int main(void)
{
    rcu_periph_clock_enable(RCU_GPIOA);
    gpio_bit_reset(GPIOA,GPIO_PIN_6);
    gpio_init(GPIOA,GPIO_MODE_OUT_PP,GPIO_OSPEED_50MHZ,GPIO_PIN_6);
    gpio_bit_set(GPIOA,GPIO_PIN_6);
    delay_nms(10);
    gpio_bit_reset(GPIOA,GPIO_PIN_6);
    while(1){

    }
}
```

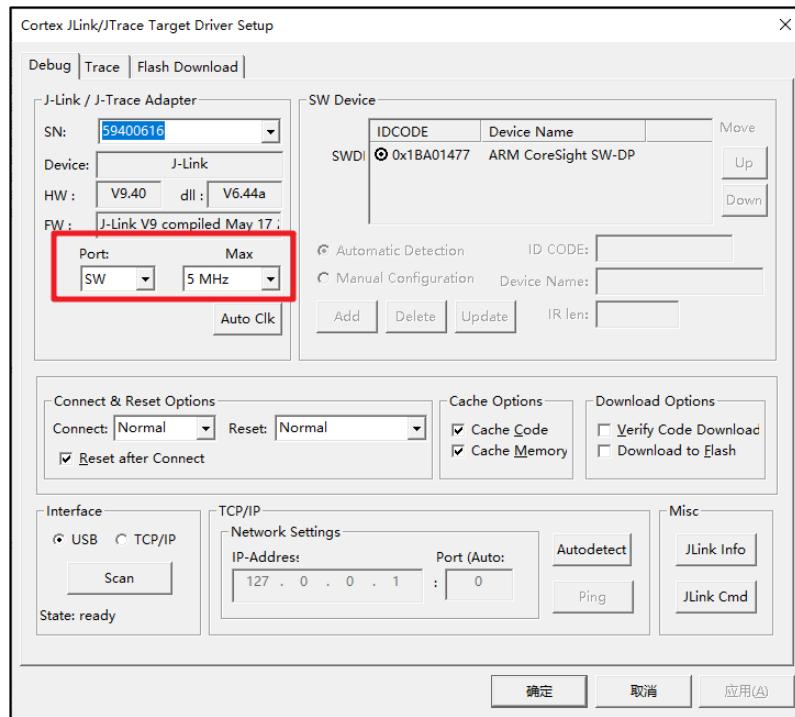
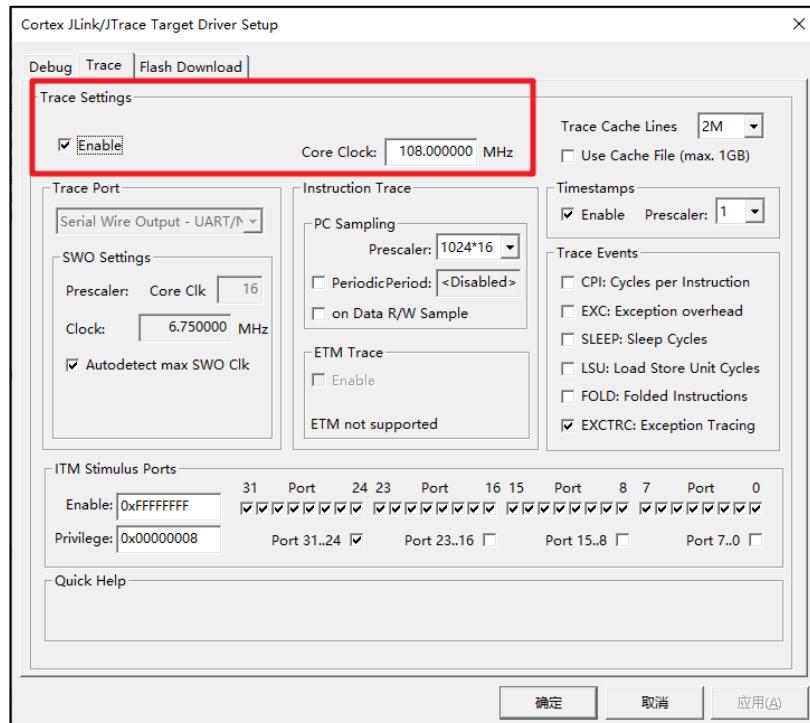
Use the logic analyzer to select the edge trigger, and the measurement results are as follows:

**Figure 2-3. Use logic analyzer to measure GPIO flip time result**



## 2.4. Measure with Keil online simulation

Use Jlink to connect to the target board, select SW Port in the Debug->setting tab, Enable Trace Setting in the Trace tab, configure Core clock as the system clock 108Mhz, click “OK”. The configuration is shown in [Figure 2-4. Configure SW port download mode](#).

**Figure 2-4. Configure SW port download mode**

**Figure 2-5. Configure Trace interface**


Enter the debugging interface, add breakpoints before and after the code to be measured, run to the breakpoint, select Reset Stop Watch(t1) in the lower right corner, clear the t1 running time, run at full speed, run to the end of the code, and view the code running time , The code running time result is shown in [Figure 2-7. Code runtime measurement](#).

## Several methods of measuring MCU code running time

Figure 2-6. Reset running time

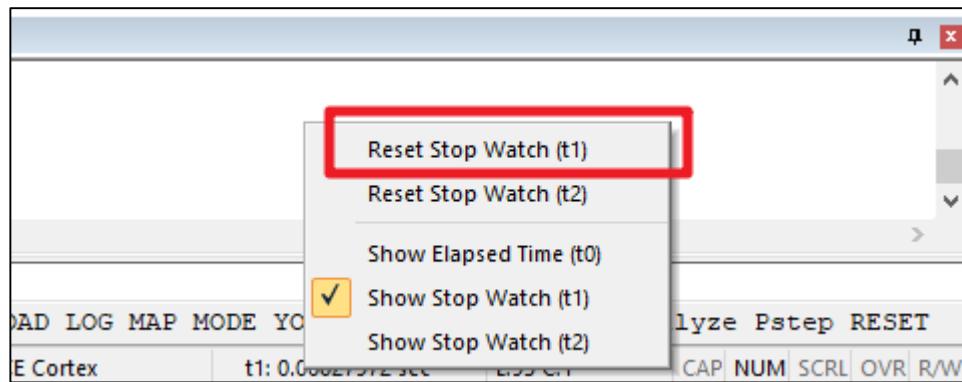
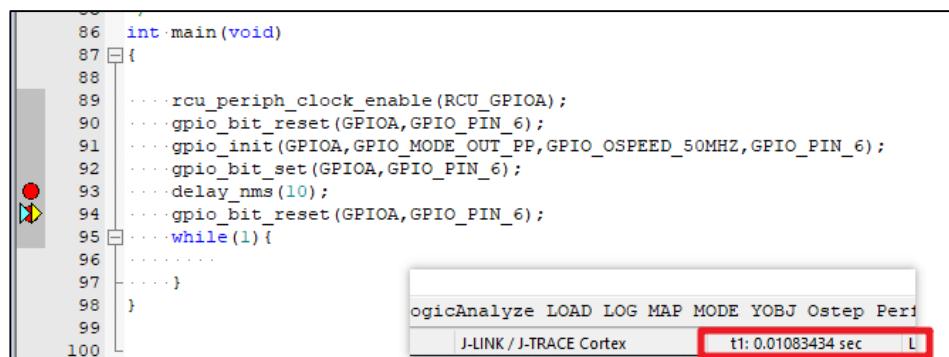


Figure 2-7. Code runtime measurement



### 3. Revision history

**Table 3-1. Revision history**

Revision No	Description	Date
1.0	Initial Release	Apr.30, 2021

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